

flow PACK 1, 600V
Maximum Ratings / Höchstzulässige Werte

Parameter	Condition	Symbol	Datasheet values	Unit
			max.	

Transistor Inverter
Transistor Wechselrichter

Collector-emitter break down voltage Kollektor-Emitter-Sperrspannung		V_{CE}	600	V
DC collector current Kollektor-Dauergleichstrom	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	I_C	22 29	A
Repetitive peak collector current Periodischer Kollektorspitzenstrom	$t_p=1\text{ms}$ $T_h=80^{\circ}\text{C}$	I_{cpuls}	44	A
Power dissipation per IGBT Verlustleistung pro IGBT	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	P_{tot}	49 74	W
Gate-emitter peak voltage Gate-Emitter-Spitzenspannung		V_{GE}	± 20	V
SC withstand time Kurzschlußverhalten	$T_j \leq 150^{\circ}\text{C}$ $V_{GE}=15\text{V}$ $V_{CE}=V_{CEBR}$	t_{SC}	10	us

Diode Inverter
Diode Wechselrichter

DC forward current Dauergleichstrom	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	I_F	31 40 *	A
Repetitive peak forward current Periodischer Spitzenstrom	$t_p=1\text{ms}$ $T_h=80^{\circ}\text{C}$	I_{FRM}	62	A
Power dissipation per Diode Verlustleistung pro Diode	$T_j=150^{\circ}\text{C}$ $T_h=80^{\circ}\text{C}$, $T_c=80^{\circ}\text{C}$	P_{tot}	41 62	W

Thermal properties
Thermische Eigenschaften

max. Chip temperature max. Chiptemperatur		T_{jmax}	150	$^{\circ}\text{C}$
Storage temperature Lagertemperatur		T_{stg}	-40...+125	$^{\circ}\text{C}$
Operation temperature Betriebstemperatur		T_{op}	-40...+125	$^{\circ}\text{C}$

Insulation properties
Modulisolation

Insulation voltage Isolationsspannung	$t=1\text{min}$	V_{is}	4000	Vdc
Creepage distance Kriechstrecke			min 12,7	mm
Clearance Luftstrecke			min 12,7	mm

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Characteristic values

Description	Symbol	Conditions					Datasheet values			Unit
		T(C°)	Other conditions (Rgon-Rgoff)	VGE(V) VGS(V)	VR(V) VCE(V) VDS(V)	IC(A) IF(A) Id(A)	Min	Typ	Max	

Transistor Inverter

Transistor Wechselrichter

Gate emitter threshold voltage Gate-Schwellenspannung	$V_{GE(th)}$	Tj=25°C Tj=125°C	$V_{CE}=V_{GE}$				0,0007	3	4	5	V
Collector-emitter saturation voltage Kollektor-Emitter Sättigungsspannung	$V_{CE(sat)}$	Tj=25°C Tj=125°C		15			30	2,21 2,49	2,65		V
Collector-emitter cut-off current incl. Diode Kollektor-Emitter Reststrom	I_{CES}	Tj=25°C Tj=125°C		0	600				0,04 3		mA
Gate-emitter leakage current Gate-Emitter Reststrom	I_{GES}	Tj=25°C Tj=125°C		25	0				200		nA
Integrated Gate resistor Integrierter Gate Widerstand	R_{gint}								-		Ohm
Turn-on delay time Einschaltverzögerungszeit	$t_{d(on)}$	Tj=25°C Tj=125°C	Rgon=24 Ohm Rgoff=12 Ohm	15	300	30			30		ns
Rise time Anstiegszeit	t_r	Tj=25°C Tj=125°C	Rgon=24 Ohm Rgoff=12 Ohm	15	300	30			20		ns
Turn-off delay time Abschaltverzögerungszeit	$t_{d(off)}$	Tj=25°C Tj=125°C	Rgon=24 Ohm Rgoff=12 Ohm	15	300	30			333		ns
Fall time Fallzeit	t_f	Tj=25°C Tj=125°C	Rgon=24 Ohm Rgoff=12 Ohm	15	300	30			21		ns
Turn-on energy loss per pulse Einschaltverlustenergie pro Puls	E_{on}	Tj=25°C Tj=125°C	Rgon=24 Ohm Rgoff=12 Ohm	15	300	30			0,677		mWs
Turn-off energy loss per pulse Abschaltverlustenergie pro Puls	E_{off}	Tj=25°C Tj=125°C	Rgon=24 Ohm Rgoff=12 Ohm	15	300	30			0,695		mWs
Input capacitance Eingangskapazität	C_{ies}	Tj=25°C Tj=125°C	f=1MHz	0	25				1,6 1,92		nF
Output capacitance Ausgangskapazität	C_{oss}	Tj=25°C Tj=125°C	f=1MHz	0	25				0,15 0,18		nF
Reverse transfer capacitance Rückwirkungskapazität	C_{rss}	Tj=25°C Tj=125°C	f=1MHz	0	25				0,092 0,110		nF
Gate charge Gate Ladung	Q_{Gate}	Tj=25°C Tj=125°C		15	480	20			140 182		nC
Thermal resistance chip to heatsink per chip Wärmewiderstand Chip-Kühlkörper pro Chip	R_{thJH}		Thermal grease thickness≤50um Wärmeleitpaste Dicke≤50um $\lambda = 0,61$ W/mK						1,43		K/W
Thermal resistance chip to case per chip Wärmewiderstand Chip-Gehäuse pro Chip	R_{thJC}								0,94		K/W
Coupled thermal resistance inverter diode-transistor	R_{thJH}		Thermal grease thickness≤50um Wärmeleitpaste Dicke≤50um $\lambda = 0,61$ W/mK						TBD		K/W
Gekoppelte Wärmewiderstand Wechselrichter Diode-Transistor											

Diode Inverter

Diode Wechselrichter

Diode forward voltage Durchlaßspannung	V_F	Tj=25°C Tj=125°C					30	1,52 1,34	1,75		V
Peak reverse recovery current Rückstromspitze	I_{RM}	Tj=25°C Tj=125°C	Rgon=24 Ohm	15	300	30			60		A
Reverse recovery time Sperrverzögerungszeit	t_{rr}	Tj=25°C Tj=125°C	Rgon=24 Ohm	15	300	30			66		ns
Reverse recovered charge Sperrverzögerungsladung	Q_{rr}	Tj=25°C Tj=125°C	Rgon=24 Ohm	15	300	30			2,29		uC
Reverse recovered energy Sperrverzögerungsenergie	E_{rec}	Tj=25°C Tj=125°C	Rgon=24 Ohm	15	300	30			0,376		mWs
Thermal resistance chip to heatsink per chip Wärmewiderstand Chip-Kühlkörper pro Chip	R_{thJH}		Thermal grease thickness≤50um Wärmeleitpaste Dicke≤50um $\lambda = 0,61$ W/mK						1,70		K/W
Thermal resistance chip to case per chip Wärmewiderstand Chip-Gehäuse pro Chip	R_{thJC}								1,12		K/W
Coupled thermal resistance inverter transistor-diode	R_{thJH}		Thermal grease thickness≤50um Wärmeleitpaste Dicke≤50um $\lambda = 0,61$ W/mK						TBD		K/W
Gekoppelte Wärmewiderstand Wechselrichter Transistor-Diode											

NTC-Thermistor

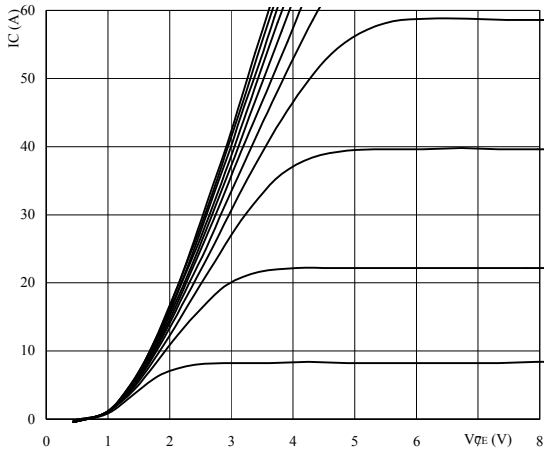
NTC-Widerstand

Rated resistance Nennwiderstand	R_{25}	Tj=25°C	Tol. ±5%					4,46	4,7	4,94	kOhm
Deviation of R100 Abweichung von R100	$D_{R/R}$	Tc=100°C	R100=226Ohm						3		%/K
Power dissipation given Epcos-Typ Verlustleistung Epcos-Typ angeben	P	Tj=25°C							210		mW
B-value B-Wert	$B_{(25/100)}$	Tj=25°C	Tol. ±3%						4500		K

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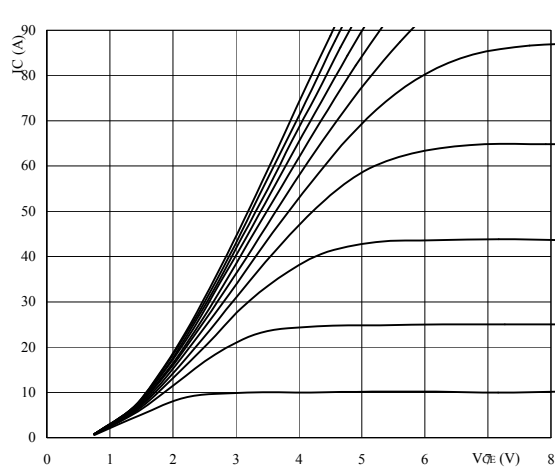
Output inverter

Figure 1. Typical output characteristics
Output inverter IGBT
 $I_c = f(V_{CE})$



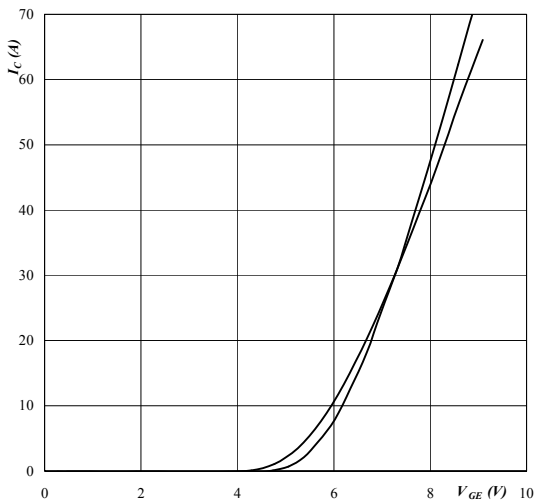
parameter: $t_p = 250 \mu s$ $T_j = 25 \text{ }^\circ C$
VGE parameter: from: 6 V to 16 V
in 1 V steps

Figure 2. Typical output characteristics
Output inverter IGBT
 $I_c = f(V_{CE})$



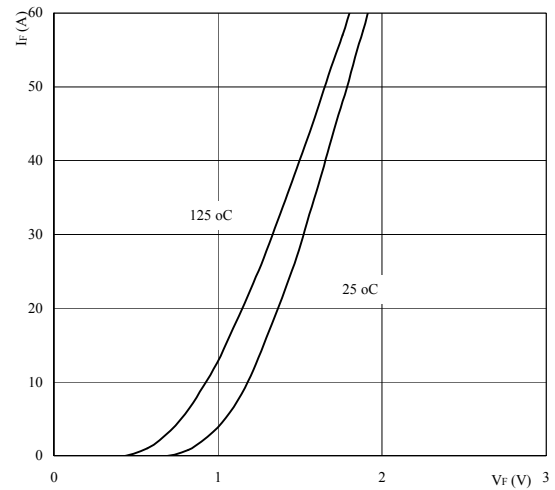
parameter: $t_p = 250 \mu s$ $T_j = 125 \text{ }^\circ C$
VGE parameter: from: 6 V to 16 V
in 1 V steps

Figure 3. Typical transfer characteristics
Output inverter IGBT
 $I_c = f(V_{GE})$



parameter: $t_p = 250 \mu s$ $V_{CE} = 16 \text{ V}$

Figure 4. Typical diode forward current as a function of forward voltage
Output inverter FRED $I_F = f(V_F)$

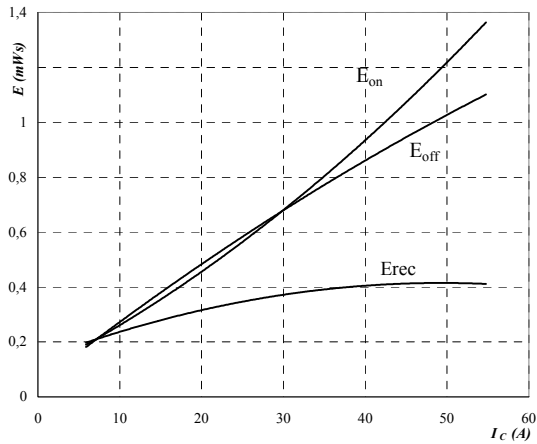


parameter: $t_p = 250 \mu s$

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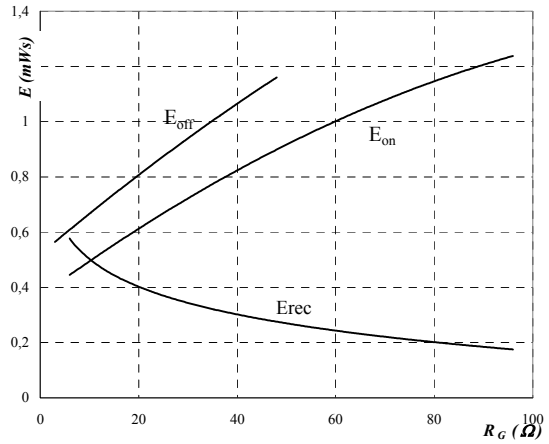
Output inverter

Figure 5. Typical switching energy losses as a function of collector current
Output inverter IGBT
 $E = f(I_c)$



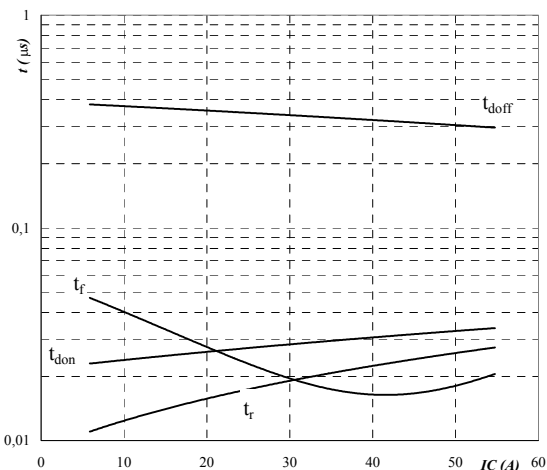
inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 300\text{ V}$
 $V_{GE} = 15\text{ V}$
 $R_{Gon} = 2 * R_{Goff} = 24\text{ }\Omega$

Figure 6. Typical switching energy losses as a function of gate resistor
Output inverter IGBT
 $E = f(R_G)$



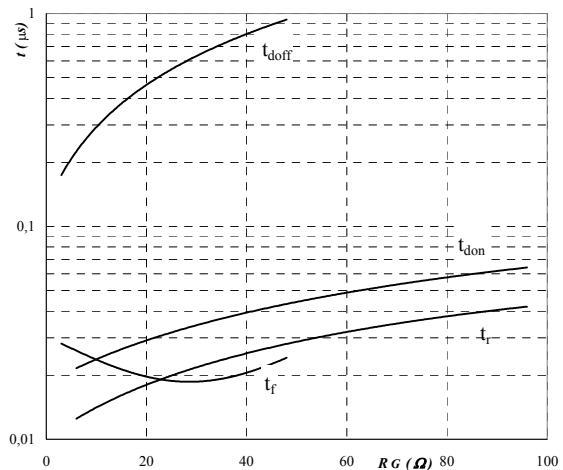
inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 300\text{ V}$
 $V_{GE} = 15\text{ V}$
 $I_c = 30\text{ A}$

Figure 7. Typical switching times as a function of collector current
Output inverter IGBT
 $t = f(I_c)$



inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 300\text{ V}$
 $V_{GE} = 15\text{ V}$
 $R_{Gon} = 2 * R_{Goff} = 24\text{ }\Omega$

Figure 8. Typical switching times as a function of gate resistor
Output inverter IGBT
 $t = f(R_G)$

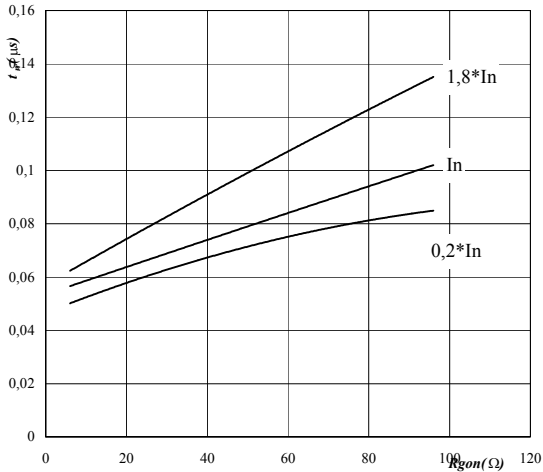


inductive load, $T_j = 125\text{ }^\circ\text{C}$
 $V_{CE} = 300\text{ V}$
 $V_{GE} = 15\text{ V}$
 $I_c = 30\text{ A}$

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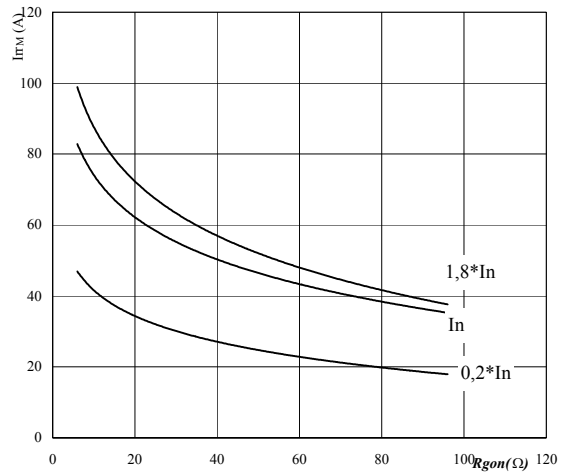
Output inverter

Figure 9. Typical reverse recovery time as a function of gate resistor
Output inverter FRED diode
 $t_{rr} = f(R_{gon})$



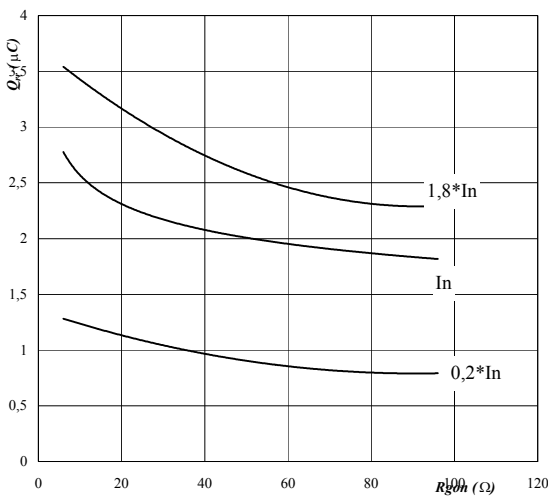
$T_j = 125 \text{ }^\circ\text{C}$
 $V_R = 300 \text{ V}$
 $I_n = 30 \text{ A}$

Figure 10. Typical reverse recovery current as a function of gate resistor
Output inverter FRED diode
 $I_{RRM} = f(R_{gon})$



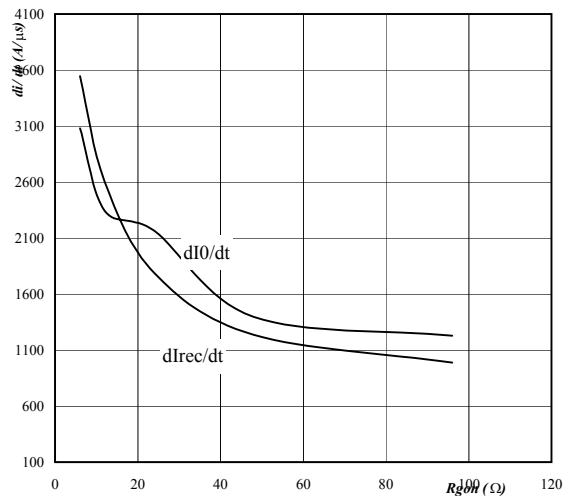
$T_j = 125 \text{ }^\circ\text{C}$
 $V_R = 300 \text{ V}$
 $I_n = 30 \text{ A}$

Figure 11. Typical reverse recovery charge as a function of gate resistor
Output inverter FRED diode
 $Q_{rr} = f(R_{gon})$



$T_j = 125 \text{ }^\circ\text{C}$
 $V_R = 300 \text{ V}$
 $I_n = 30 \text{ A}$

Figure 12. Typical diode peak rate of fall of forward and reverse recovery current as a function of gate resistor
Output inverter FRED diode
 $di/dt, dlrec/dt = f(R_{gon})$

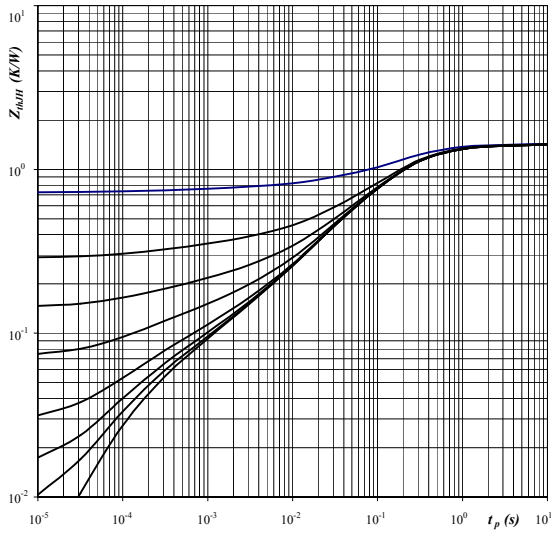


$T_j = 125 \text{ }^\circ\text{C}$
 $V_R = 300 \text{ V}$
 $I_F = 30 \text{ A}$

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Output inverter

Figure 13. IGBT transient thermal impedance as a function of pulse width
 $Z_{thJH} = f(t_p)$

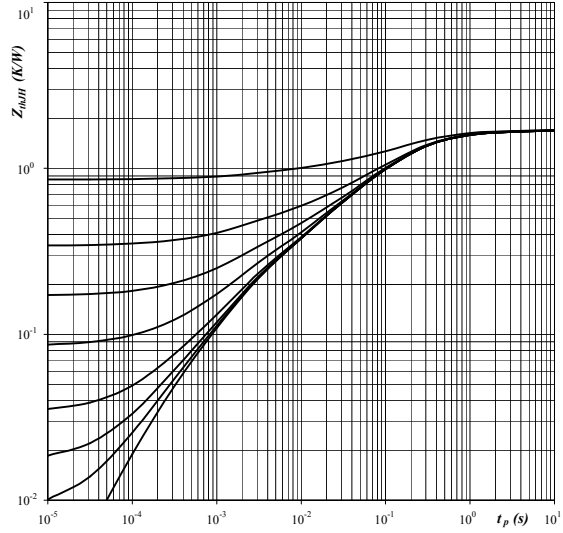


Parameter: $D = t_p / T$ RthJH 1,43 K/W

IGBT thermal model values

R (C/W)	Tau (s)
0,03	6,1E+01
0,10	2,2E+00
0,48	3,3E-01
0,56	9,8E-02

Figure 14. FRED transient thermal impedance as a function of pulse width
 $Z_{thJH} = f(t_p)$



Parameter: $D = t_p / T$ RthJH 1,70 K/W

FRED thermal model values

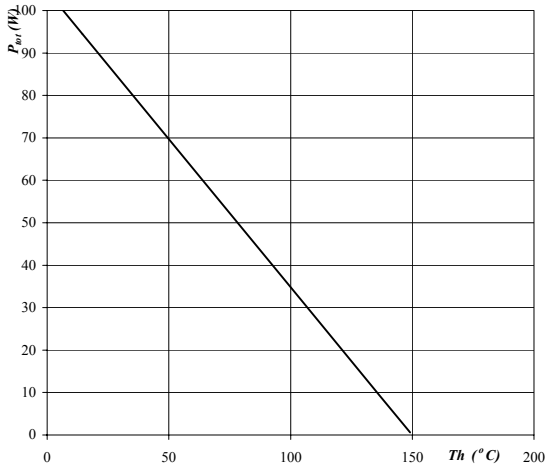
R (C/W)	Tau (s)
0,03	3,5E+01
0,12	1,9E+00
0,57	3,0E-01
0,60	8,1E-02

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Output inverter

Figure 15. Power dissipation as a function of heatsink temperature

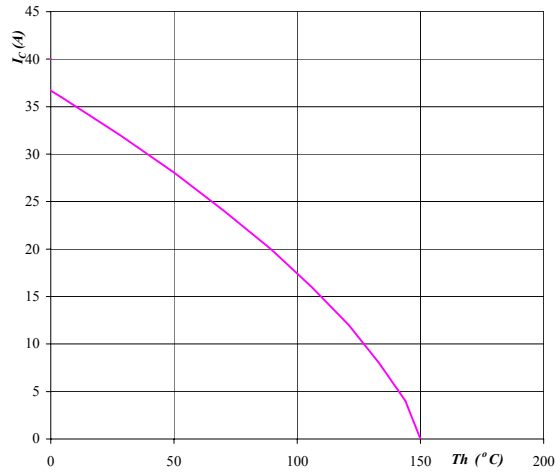
Output inverter IGBT
 $P_{tot} = f(T_h)$



parameter: T_j = 150°C

Figure 16. Collector current as a function of heatsink temperature

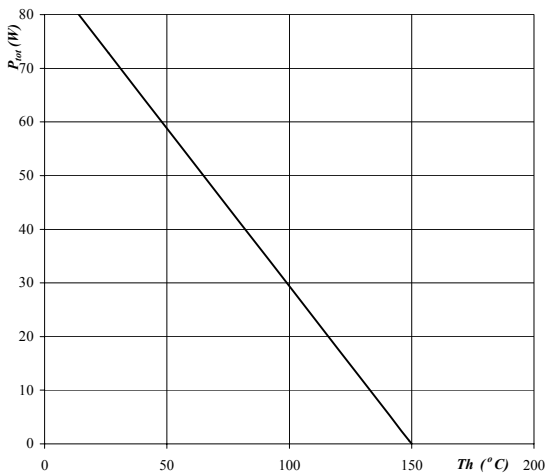
Output inverter IGBT
 $I_c = f(T_h)$



parameter: T_j = 150°C
V_{GE} = 15 V

Figure 17. Power dissipation as a function of heatsink temperature

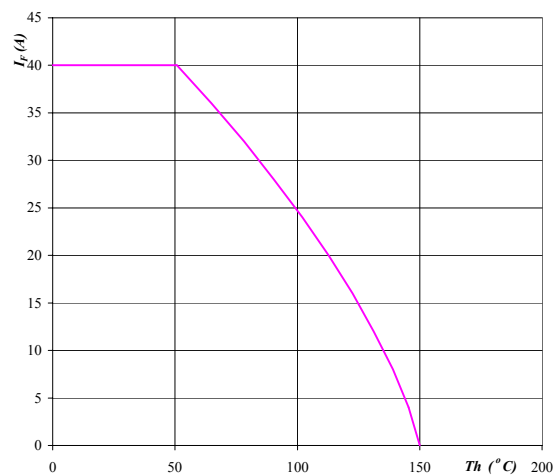
Output inverter FRED
 $P_{tot} = f(T_h)$



parameter: T_j = 150°C

Figure 18. Forward current as a function of heatsink temperature

Output inverter FRED
 $I_F = f(T_h)$



parameter: T_j = 150°C